

## P-Channel 30-V (D-S) 175 °C MOSFET

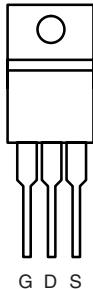
### PRODUCT SUMMARY

$V_{DS}$ (V)	$r_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>a</sup>
- 30	0.007 at $V_{GS} = - 10$ V	$\pm 75$
	0.010 at $V_{GS} = - 4.5$ V	$\pm 75$



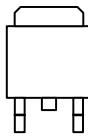
**RoHS\***  
COMPLIANT

TO-220AB



DRAIN connected to TAB

TO-263

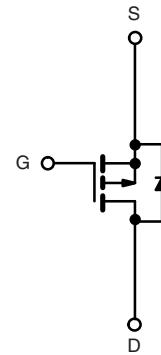


SUB75P03-07

Top View

SUP75P03-07

**Ordering Information:** SUB75P03-07 (TO-263)  
SUB75P03-07-E3 (TO-263, Lead (Pb)-free)  
SUP75P03-07 (TO-220AB)  
SUP75P03-07-E3 (TO-220AB, Lead (Pb)-free)



P-Channel MOSFET

### ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current ( $T_J = 175$ °C)	$I_D$	- 75 <sup>a</sup>	A
$T_C = 125$ °C		- 65	
Pulsed Drain Current	$I_{DM}$	- 240	
Avalanche Current	$I_{AR}$	- 60	
Repetitive Avalanche Energy <sup>b</sup>	$E_{AR}$	180	mJ
Power Dissipation	$P_D$	187 <sup>d</sup>	W
$T_A = 25$ °C (TO-263)		3.75	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to 175	°C

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Limit	Unit
Junction-to-Ambient	$R_{thJA}$	40	°C/W
Free Air (TO-220AB)		62.5	
Junction-to-Case	$R_{thJC}$	0.8	

Notes:

- a. Package limited.
- b. Duty cycle  $\leq 1$  %.
- c. When Mounted on 1" square PCB (FR-4 material).
- d. See SOA curve for voltage derating.

\* Pb containing terminations are not RoHS compliant, exemptions may apply.

**SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250 \mu\text{A}$	- 1		- 3	
Gate-Body Leakage	$I_{\text{GSS}}$	$V_{\text{DS}} = 0 \text{ V}, V_{\text{GS}} = \pm 20 \text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = -30 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			- 1	$\mu\text{A}$
		$V_{\text{DS}} = -30 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 125^\circ\text{C}$			- 50	
		$V_{\text{DS}} = -30 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 175^\circ\text{C}$			- 250	
On-State Drain Current <sup>a</sup>	$I_{\text{D}(\text{on})}$	$V_{\text{DS}} = -5 \text{ V}, V_{\text{GS}} = -10 \text{ V}$	- 120			A
Drain-Source On-State Resistance <sup>a</sup>	$r_{\text{DS}(\text{on})}$	$V_{\text{GS}} = -10 \text{ V}, I_D = -30 \text{ A}$		0.0055	0.007	$\Omega$
		$V_{\text{GS}} = -10 \text{ V}, I_D = -30 \text{ A}, T_J = 125^\circ\text{C}$			0.010	
		$V_{\text{GS}} = -10 \text{ V}, I_D = -30 \text{ A}, T_J = 175^\circ\text{C}$			0.013	
		$V_{\text{GS}} = -4.5 \text{ V}, I_D = -20 \text{ A}$		0.008	0.010	
Forward Transconductance <sup>a</sup>	$g_{\text{fs}}$	$V_{\text{DS}} = -15 \text{ V}, I_D = -75 \text{ A}$	20			S
<b>Dynamic<sup>b</sup></b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = -25 \text{ V}, f = 1 \text{ MHz}$		9000		$\text{pF}$
Output Capacitance	$C_{\text{oss}}$			1565		
Reversen Transfer Capacitance	$C_{\text{rss}}$			715		
Total Gate Charge <sup>c</sup>	$Q_g$	$V_{\text{DS}} = -15 \text{ V}, V_{\text{GS}} = -10 \text{ V}, I_D = -75 \text{ A}$		160	240	$\text{nC}$
Gate-Source Charge <sup>c</sup>	$Q_{\text{gs}}$			32		
Gate-Drain Charge <sup>c</sup>	$Q_{\text{gd}}$			30		
Turn-On Delay Time <sup>c</sup>	$t_{\text{d}(\text{on})}$			25	40	
Rise Time <sup>c</sup>	$t_r$	$V_{\text{DD}} = -15 \text{ V}, R_L = 0.2 \Omega$ $I_D \approx -75 \text{ A}, V_{\text{GEN}} = -10 \text{ V}, R_G = 2.5 \Omega$		225	360	$\text{ns}$
Turn-Off Delay Time <sup>c</sup>	$t_{\text{d}(\text{off})}$			150	240	
Fall Time <sup>c</sup>	$t_f$			210	340	
<b>Source-Drain Diode Ratings and Characteristics</b> ( $T_C = 25^\circ\text{C}$ ) <sup>b</sup>						
Continuous Current	$I_S$	$I_F = -75 \text{ A}, V_{\text{GS}} = 0 \text{ V}$ $I_F = -75 \text{ A}, \text{di/dt} = 100 \text{ A}/\mu\text{s}$			- 75	$\text{A}$
Pulsed Current	$I_{\text{SM}}$				- 240	
Forward Voltage <sup>a</sup>	$V_{\text{SD}}$			- 1.2	- 1.5	V
Reverse Recovery Time	$t_{\text{rr}}$			55	100	ns
Peak Reverse Recovery Current	$I_{\text{RM}(\text{REC})}$			2.5	5	A
Reverse Recovery Charge	$Q_{\text{rr}}$			0.07	0.25	$\mu\text{C}$

Notes:

- a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2 \%$ .
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.